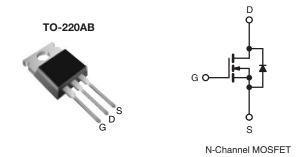


Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	10	100				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.077				
Q _g (Max.) (nC)	7:	72				
Q _{gs} (nC)	1	11				
Q _{gd} (nC)	32	32				
Configuration	Sin	Single				



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- 175 °C Operating Temperature
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF540PbF		
Lead (FD)-life	SiHF540-E3		
SnPb	IRF540		
SIFD	SiHF540		

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	100	V	
Gate-Source Voltage			V_{GS}	± 20	7 v	
Continuous Drain Current		T _C = 25 °C		28		
	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	I _D	20	А	
Pulsed Drain Current ^a			I _{DM}	110		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	230	mJ	
Repetitive Avalanche Current ^a			I _{AR}	28	Α	
Repetitive Avalanche Energy ^a			E _{AR}	15	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	150	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	- °C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d	7	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 440 \,\mu\text{H}$, $R_g = 25 \,\Omega$, $I_{AS} = 28 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le 28$ A, $dI/dt \le 170$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST (MIN.	TYP.	MAX.	UNIT	
Static						•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	' _{GS} , I _D = 250 μA	2.0	=	4.0	٧
Gate-Source Leakage	I _{GSS}	VG	_{aS} = ± 20 V	1	-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} = 100 V, V _{GS} = 0 V		1	-	25	, , ,
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 80 \text{ V}, \text{ V}$	_{'GS} = 0 V, T _J = 150 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 17 A ^b	1	-	0.077	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = \xi$	$50 \text{ V}, I_D = 17 \text{ A}^b$	8.7	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V	$t_{GS} = 0 \text{ V},$	ı	1700	-	pF
Output Capacitance	C _{oss}	V	_{DS} = 25 V,	-	560	-	
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		-	120	-	
Total Gate Charge	Q_g		I _D = 17 A, V _{DS} = 80 V,	-	-	72	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	11	
Gate-Drain Charge	Q _{gd}	see fig. 6 and 13 ^b		-	-	32	1
Turn-On Delay Time	t _{d(on)}	V_{DD} = 50 V, I_{D} = 17 A R_{g} = 9.1 Ω , R_{D} = 2.9 Ω , see fig. 10 ^b		-	11	-	- ns
Rise Time	t _r			-	44	-	
Turn-Off Delay Time	t _{d(off)}			-	53	-	
Fall Time	t _f			-	43	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	28	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	110	A
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 28 A, V _{GS} = 0 V ^b		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 17 A, dI/dt = 100 A/μs ^b		-	180	360	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.3	2.8	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

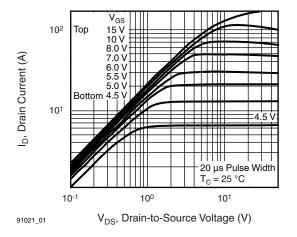


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

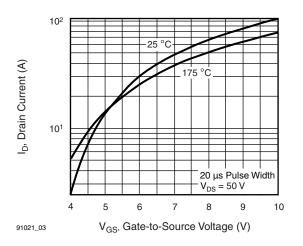


Fig. 3 - Typical Transfer Characteristics

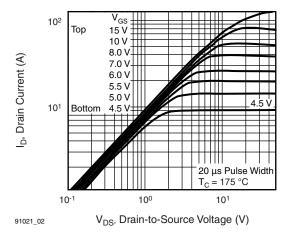


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

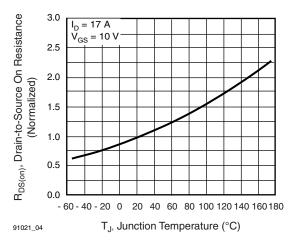
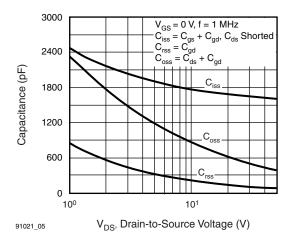


Fig. 4 - Normalized On-Resistance vs. Temperature

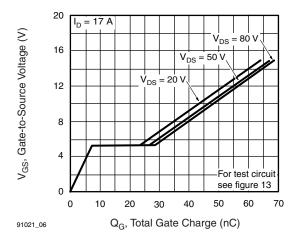




I_{SD}, Reverse Drain Current (A) 10¹ 100 $V_{GS} = 0 V$ 10-1 0.4 1.6 0.8 V_{SD}, Source-to-Drain Voltage (V) 91021_07

Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

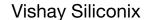
Fig. 7 - Typical Source-Drain Diode Forward Voltage



10³ Operation in this area limited I_D, Drain Current (A) 10² = 175 °C Single Pulse 5 10 2 2 ⁵ 10³ ² V_{DS}, Drain-to-Source Voltage (V) 91021_08

Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

Fig. 8 - Maximum Safe Operating Area





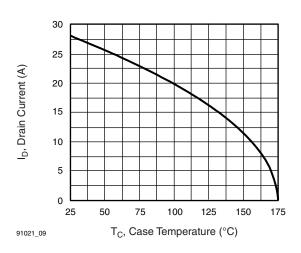


Fig. 9 - Maximum Drain Current vs. Case Temperature

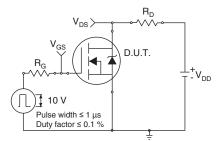


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

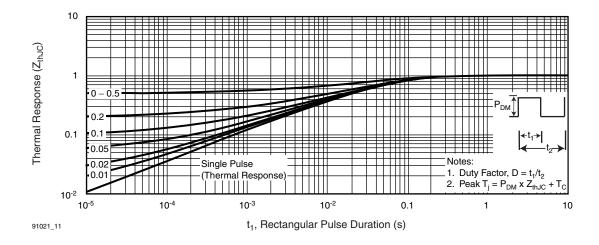


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



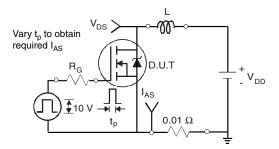


Fig. 12a - Unclamped Inductive Test Circuit

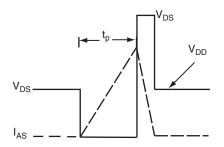


Fig. 12b - Unclamped Inductive Waveforms

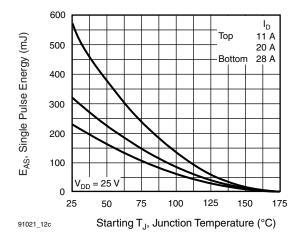


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

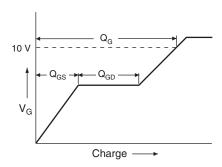


Fig. 13a - Basic Gate Charge Waveform

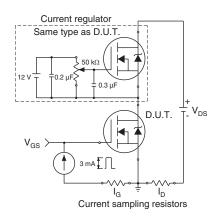
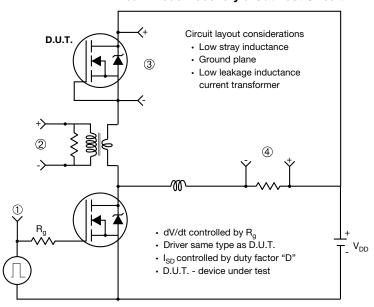


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



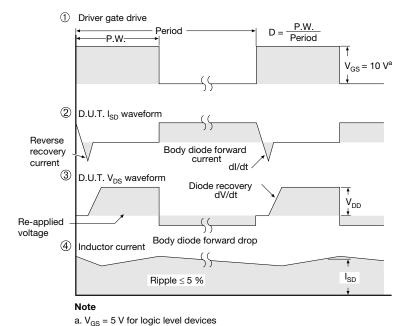
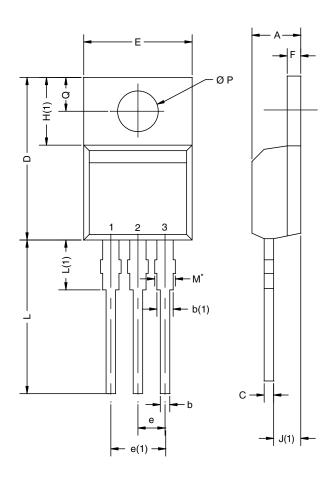


Fig. 14 - For N-Channel

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TO-220AB



	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØΡ	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: T13-0724-Rev. O, 14-Oct-13						

DWG: 5471

Note

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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Revision: 02-Oct-12 Document Number: 91000

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